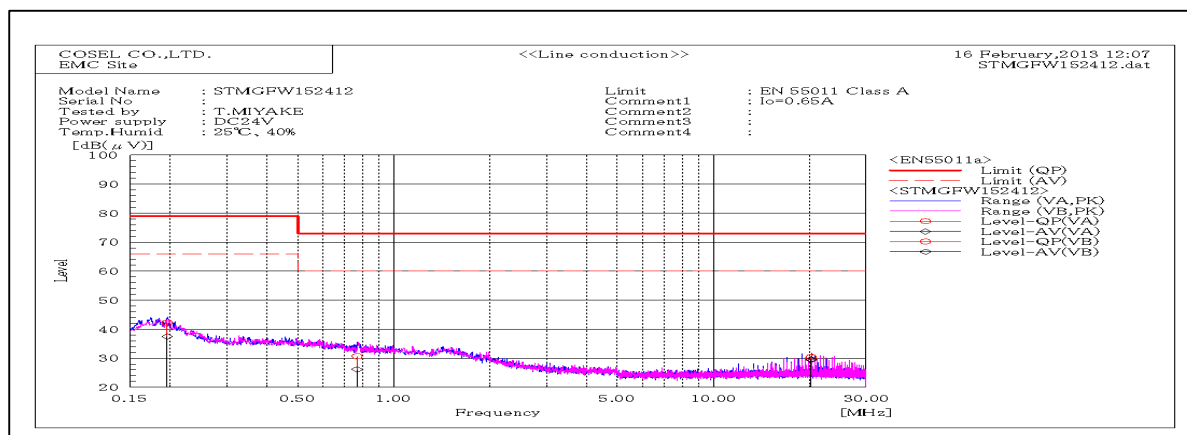
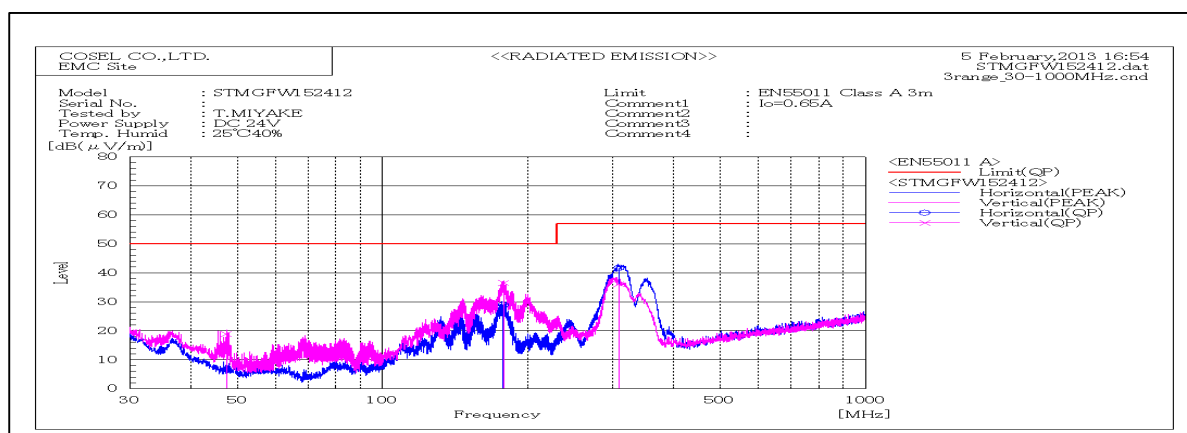


DATA SHEET		Date	18-Feb-13
Model	STMGFW152412	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake



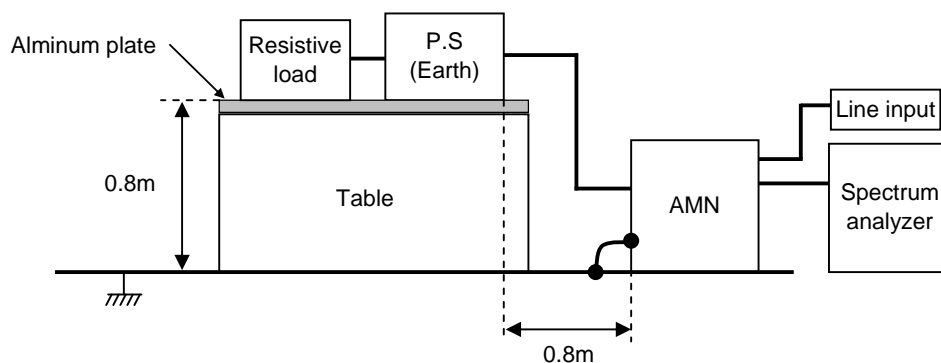
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.19531		VA	22.1	17.3	20.2	42.3	37.5	79	66	36.7	28.5	Pass	
0.76799		VA	10.6	6.1	20.1	30.7	26.2	73	60	42.3	33.8	Pass	
20.2004		VB	9.2	8.4	21.2	30.4	29.6	73	60	42.6	30.4	Pass	
20.1995		VA	9.1	8.3	21.2	30.3	29.5	73	60	42.7	30.5	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)		Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	AV						
47.476	V	Stable	41.4		-22.5	18.9		50	31.1	Pass	104	343	
177.938	V	Stable	52.5		-16	36.5		50	13.5	Pass	102	301	
177.929	H	Stable	51.2		-22.3	28.9		50	21.1	Pass	150	256	
308.908	V	Stable	53.3		-17.2	36.1		57	20.9	Pass	106	272	
308.866	H	Stable	59.1		-17.3	41.8		57	15.2	Pass	106	87	

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

1. Line conduction



2. Radiated emission

